


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/681,167	FUKADA ET AL.	
	Examiner	Art Unit	
	Anthony H. Nguyen	2854	

SEARCHED			
Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
US EAST (text search classes 399/364,401,402,361; 271/301, 302,184, see the search history print out)	12/17/2007	HAI/
Text search (USPAT, PGPUB, EPO,JPO, DERWENT, IBM_TDBM USOCR, FPRS, see the search history print out)	12/17/2007	HAI/